

Notice of References Cited	Application/Control No. 10/791,451		Applicant(s)/Patent Under Reexamination WIZEL ET AL.	
	Examiner Mark L. Berch		Art Unit 1624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0153757 A1	08-2003	Etinger et al.	544/276
*	B	US-2004/0197396 A1	10-2004	Fain et al.	424/464
*	C	US-6,849,736 B2	02-2005	Wizel et al.	544/276
*	D	US-6,849,737 B2	02-2005	Etinger et al.	544/276
*	E	US-2005/0059684 A1	03-2005	Dolitzky et al.	514/263.38
*	F	US-2005/0085491 A1	04-2005	Lifshitz et al.	514/263.38
*	G	US-2005/0130993 A1	06-2005	Etinger et al.	514/263.38
*	H	US-2005/0187229 A1	08-2005	Wizel et al.	514/263.38
*	I	US-2005/0192296 A1	09-2005	Harel et al.	514/263.38
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
X	N	WO 9725989 A1	07-1997	World Intellect	DELEHANTY et al.	
X	O	WO 9725989 A1	07-1997	World Intellect	DELEHANTY et al.	
X	P	WO 9727194 A1	07-1997	World Intellect	ARZENO et al.	
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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